JJMICROELECTRONICS

60V, 14A, 9.4mΩ N-channel Power SGT MOSFET JMSL0608PP

Features

- Excellent $R_{\text{DS}(\text{ON})}$ and Low Gate Charge
- 100% UIS Tested
- 100% ΔVds Tested
- Halogen-free; RoHS-compliant
- Pb-free plating

Applications

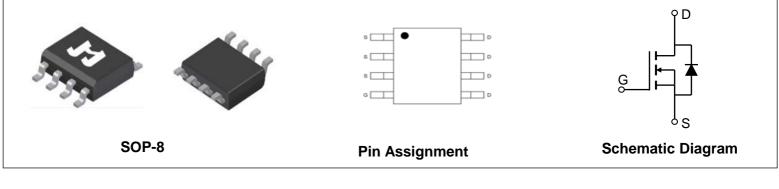
- Load Switch
- PWM Application
- Power Management

Product Summary

Parameters	Value	Unit
V _{DSS}	60	V
V _{GS(th)_Typ}	1.7	V
I _D (@V _{GS} =10V)	14	А
R _{DS(ON)_Typ} (@V _{GS} =10V	7.9	mΩ
R _{DS(ON)_Typ} (@V _{GS} =4.5V	9.4	mΩ







Ordering Information

Device	Marking	MSL	Form	Package	Reel(pcs)	Per Carton (pcs)
JMSL0608PP	SL0608P	3	Tape&Reel	SOP-8	4000	48000

Absolute Maximum Ratings (@ $T_A = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter		Value	Unit
V _{DS}	Drain-to-Source Voltage	Drain-to-Source Voltage		V
V _{GS}	Gate-to-Source Voltage		±20	V
1-	Continuous Drain Current	$T_A = 25^{\circ}C$	14	А
Ι _D		$T_{A} = 100^{\circ}C$	10	~
I _{DM}	Pulsed Drain Current ⁽¹⁾		Refer to Fig.4	A
E _{AS}	Single Pulsed Avalanche Energy ⁽²⁾		74	mJ
P _D	Power Dissipation	$T_A = 25^{\circ}C$	2.8	W
		T _A = 100°C	1	٧V
T _J , T _{STG}	Junction & Storage Temperature Range		-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Мах	Unit
R_{\thetaJA}	Thermal Resistance, Junction to Ambient ⁽³⁾	65	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient ⁽⁴⁾	45	C/ VV

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Cha	aracteristics					
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	60	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 48V, V_{GS} = 0V$	-	-	1.0	μA
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Cha	racteristics	•				
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, \ I_D = 250 \mu A$	1.2	1.7	2.3	V
		$V_{GS} = 10V, I_D = 12A$	-	7.9	9.9	mΩ
R _{DS(ON)}	Static Drain-Source ON-Resistance ⁽⁵⁾	$V_{GS} = 4.5 V, I_{D} = 6 A$	-	9.4	11.7	mΩ
Dynami	ic Characteristics					
R_g	Gate Resistance	f = 1MHz	-	2	-	Ω
C _{iss}	Input Capacitance		841	1178	1590	pF
C _{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 30V,$ f = 1MHz	367	513	693	pF
C _{rss}	Reverse Transfer Capacitance		24	34	45	pF
Qg	Total Gate Charge		15	21	29	nC
Q _{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 4.5V$ $V_{DS} = 30V, I_D = 15A$	-	3.9	-	nC
Q_{gd}	Gate Drain("Miller") Charge	$V_{\rm DS} = 500$, $I_{\rm D} = 15$ A	-	4.7	-	nC
_		•		•	•	
Switchi	ng Characteristics			1	1	-
t _{d(on)}	Turn-On DelayTime		-	7	-	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 30V$	-	24	-	ns
t _{d(off)}	Turn-Off DelayTime	I_D = 15A, R_{GEN} = 3 Ω	-	22	-	ns
t _f	Turn-Off Fall Time		-	6	-	ns
Body D	iode Characteristics					
۱ _S	Maximum Continuous Body Diode Forward Current		-	-	14	А
I _{SM}	Maximum Pulsed Body Diode Forward Curr	Forward Current		-	55	А
V_{SD}	Body Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 12A$	-		1.2	V
trr	Body Diode Reverse Recovery Time	1 - 150 di/dt = 1000/mm	23	32	43	ns
Qrr	Body Diode Reverse Recovery Charge	I _F = 15A, di/dt = 100A/us	-	24	-	nC

Electrical Characteristics ($T_J = 25^{\circ}C$ unless otherwise specified)

Notes: 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

2. E_{AS} condition: Starting T_J =25C, V_{DD} =30V, V_G =10V, R_G =25ohm, L=3mH, I_{AS} =7A, V_{DD} =0V during time in avalanche.

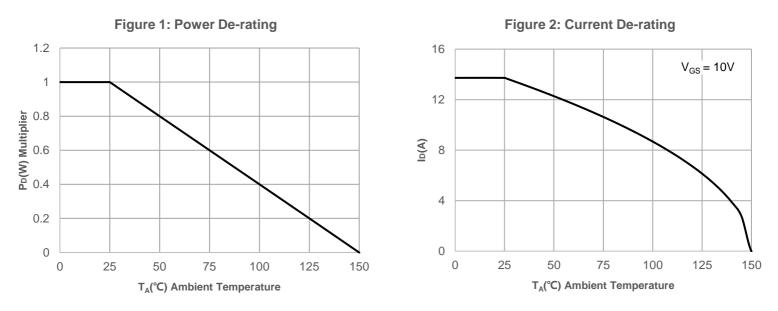
3. $R_{\theta JA}$ is measured with the device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

4. $R_{\theta JA}$ is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB.

5. Pulse Test: Pulse Width ${\leqslant}300\mu\text{s},$ Duty Cycle ${\leqslant}0.5\%.$

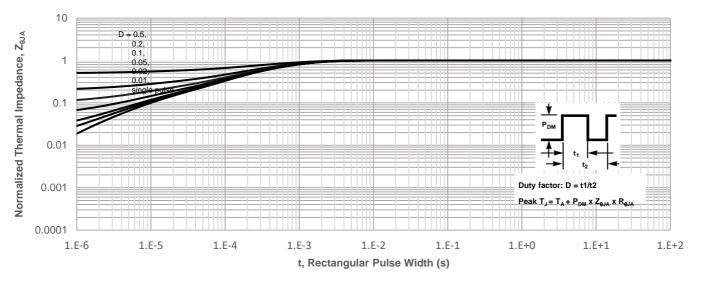




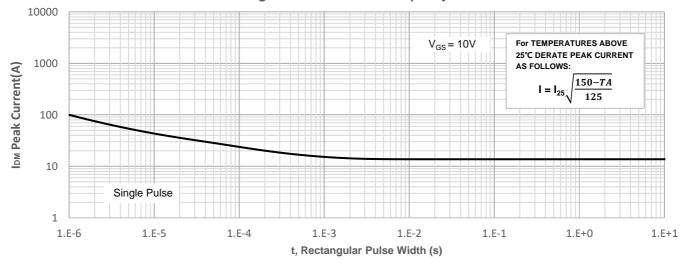


Typical Performance Characteristics

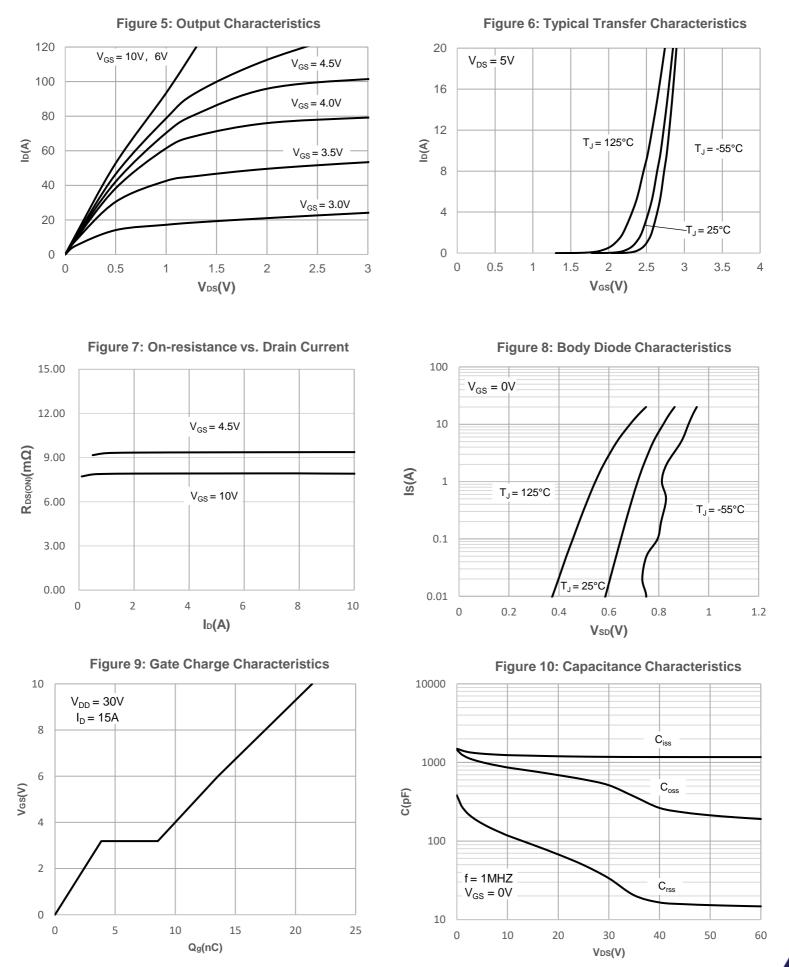








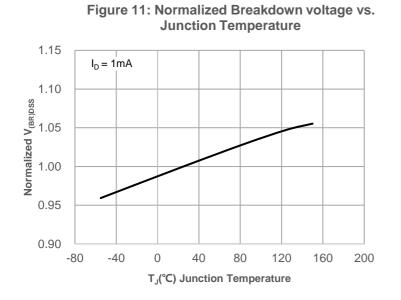




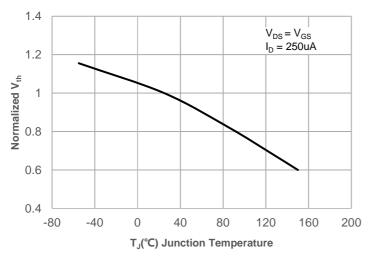
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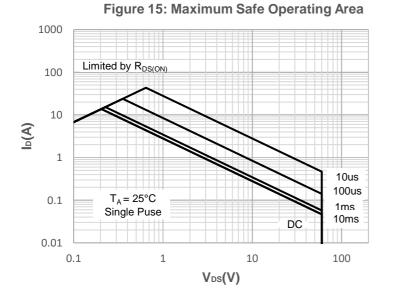
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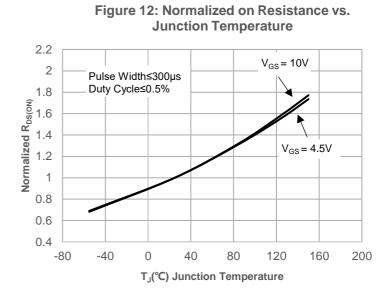


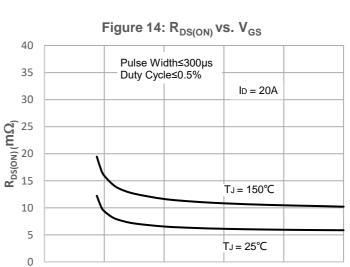




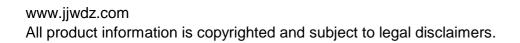








 $V_{GS}(V)$





Test Circuit

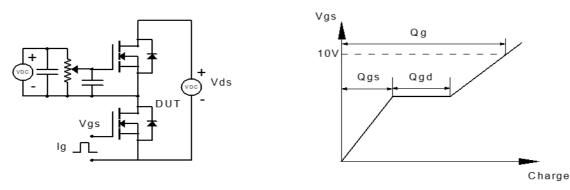


Figure 1: Gate Charge Test Circuit & Waveform

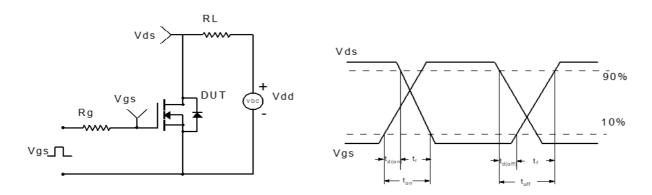


Figure 2: Resistive Switching Test Circuit & Waveform

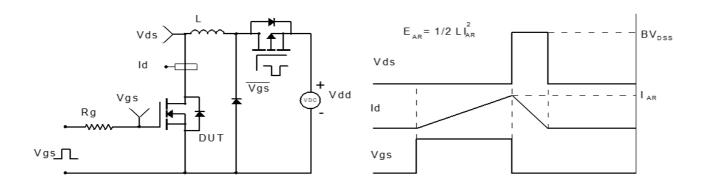


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

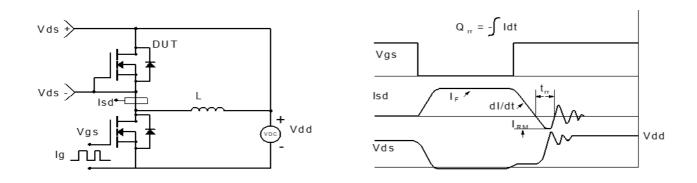
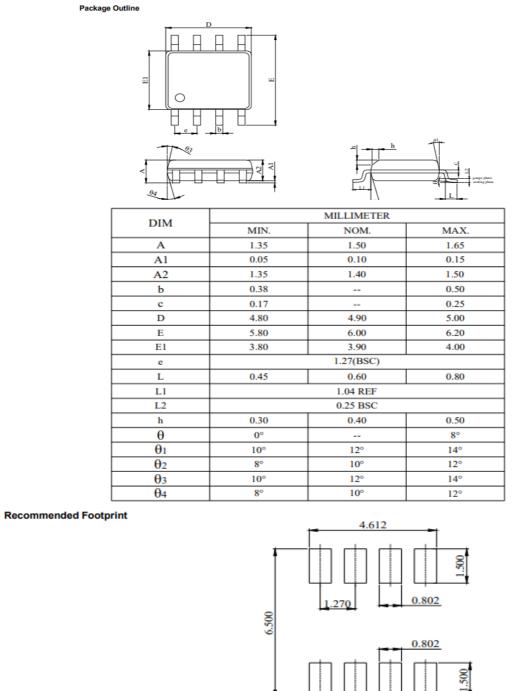


Figure 4: Diode Recovery Test Circuit & Waveform



Package Mechanical Data(SOP-8)



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